

VOICE 2008

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In September, Verigy hosted VOICE, the third annual V93000 and V5000 Series Users and Partners group meeting. The event was attended by almost 300 test engineers and managers from around the world, representing nearly 60 companies, including the top foundries, fabless semiconductor companies and independent device manufacturers (IDMs), as well as Verigy's partners. This group of semiconductor test industry thought leaders gathered to exchange information with their peers on the latest test techniques and best practices.



Sixty-four technical presentations were given by Verigy customer, partner and employee experts along the conference's six track themes:

- Productivity Software and Tools
- Communications and RF
- High Speed and Memory Test Solutions
- DC and Mixed Signal
- High-Speed Digital
- Test Techniques and Methodologies.

The presentations were selected from the more than 120 abstracts submitted, a 70 percent increase in submissions each year since the inaugural event in 2006. Twelve roundtables held at VOICE provided an opportunity for attendees to participate in information-sharing panel discussions with Verigy representatives on a range of technical topics on semiconductor test.



This year, attendees also had the opportunity to visit kiosks where they could meet one-on-one with Verigy's R&D management to discuss the newest software releases.

The event's notable panel discussion was lead by Dan Hutcheson of VLSI Research. On the panel were Sanjiv Taneja of Cadence, Raymond Lee of NANO ISI, Scott Gatzemeier of IMFT, Octavio Martinez of Qualcomm and John Chen of nVidia.

The keynote presentation given by Bill McClean of IC Insights was well received by attendees. In addition, VOICE 2008 featured a popular Suppliers Expo with representatives from 21 Verigy partner companies available to provide information for Verigy customers.

